TEST REPORT

Reference No. : WTS17S1195179-1E

FCC ID : 2ALR9-KDL-BT1512

Applicant.....: SHENZHEN G-KINDLY ELECTRONIC CO., LTD

Address...... 4F, No. 8 Fifth Road, Loucun First Industry Zone, GongMing Town,

GuangMing New District, Shenzhen, China

Manufacturer: SHENZHEN G-KINDLY ELECTRONIC CO., LTD

Address...... 4F, No. 8 Fifth Road, Loucun First Industry Zone, GongMing Town,

GuangMing New District, Shenzhen, China

Product: WIRELESS SPEAKER

Model(s) KDL-BT1512, BB871, MP9863, BIG-590, BIG-592, BIG-593,

MEN-854, MP6993, CSBT-329

Standards.....: FCC CFR47 Part 15.247:2017

Date of Receipt sample : 2017-11-04

Date of Test : 2017-11-05 to 2017-12-13

Date of Issue : 2017-12-14

Test Result..... : Pass

Remarks:

The results shown in this test report refer only to the sample(s) tested, this test report cannot be reproduced, except in full, without prior written permission of the company. The report would be invalid without specific stamp of test institute and the signatures of compiler and approver.

Prepared By:

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Compiled by:

Robin Zhōu / Test Engineer

Approved by:

1 Laboratories Introduction

Waltek Services Test Group Ltd. is one of the largest and the most comprehensive third party testing organizations in China, our headquarter located in Shenzhen (CNAS Registration No. L3110, A2LA Certificate Number: 4243.01) and have branches in Foshan (CNAS Registration No. L6478), Dongguan (CNAS Registration No. L9950), Zhongshan, Suzhou (CNAS Registration No. L7754), Ningbo and Hong Kong, Our test capability covered four large fields: safety test. Electronic Magnetic Compatibility(EMC), reliability and energy performance, Chemical test. Meanwhile, Waltek has got recognition as registration and accreditation laboratory from EMSD (Electrical and Mechanical Services Department), and American Energy star, FCC(The Federal Communications Commission), CPSC(Consumer Product Safety Commission), CEC(California energy efficiency), IC(Industry Canada) and ELI(Efficient Lighting Initiative). It's the strategic partner and data recognition laboratory of international authoritative organizations, such as UL, Intertek(ETL-SEMKO), CSA, TÜV Rheinland, TÜV SÜD, etc. As a professional, comprehensive, justice international test organization, we still keep the scientific and rigorous work attitude to help each client satisfy the international standards and assist their product enter into globe market smoothly.

Waltek Services (Shenzhen) Co., Ltd.

A. Accreditations for Conformity Assessment (International)

Country/Region	Accreditation Body	Scope	Note
USA		FCC ID \ DOC \ VOC	1
Canada	CNIAC	IC ID \ VOC	2
Japan	CNAS	MIC-T \ MIC-R	-
Europe	─ (Registration No.: L3110) — A2LA	EMCD \ RED	-
Taiwan	(Certificate No.: 4243.01)	NCC	-
Hong Kong	(Gertificate No.: 4243.01)	OFCA	-
Australia		RCM	-
India		WPC	-
Thailand	International Services	NTC	-
Singapore		IDA	-
N			

Note:

- 1. FCC Designation No.: CN1201. Test Firm Registration No.: 523476.
- 2. IC Canada Registration No.: 7760A

B. TCBs and Notify Bodies Recognized Testing Laboratory.

Recognized Testing Laboratory of	Notify body number
TUV Rheinland	
Intertek	Ontional
TUV SUD	Optional.
SGS	
Phoenix Testlab GmbH	0700
Element Materials Technology Warwick Ltd	0891
Timco Engineering, Inc.	1177
Eurofins Product Service GmbH	0681

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3 Revision History

Test report No.	Date of Receipt sample	Date of Test	Date of Issue	Purpose	Comment	Approved
WTS17S1195179-1E	2017-11-04	2017-11-05 to 2017-12-13	2017-12-14	original	-	valid

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4 General Information

4.1 General Description of E.U.T

Product	: WIRELESS SPEAKER
Model(s)	: KDL-BT1512, BB871, MP9863, BIG-590, BIG-592, BIG-593, MEN-854, MP6993, CSBT-329
Model Description	: Only the color, model names and brand names are different for different market requirement. The model KDL-BT1512 is the tested sample.
Hardware Version	: V1.2
Software Version	: V3.0

4.2 Details of E.U.T

Operation Frequency	: 2402~2480MHz
Type of Modulation	: GFSK, π /4 DQPSK,8DPSK
Antenna installation	: PCB Printed Antenna
Antenna Gain	: 0dBi
Ratings	: DC 3.7V, 1200mAh by Lithium Battery; Charging: DC 5V by USB Port

4.3 Channel List

Bluetooth Classic mode

Channel No.	Frequency (MHz)	Channel No.	Frequency (MHz)	Channel No.	Frequency (MHz)	Channel No.	Frequency (MHz)
0	2402	1	2403	2	2404	3	2405
4	2406	5	2407	6	2408	7	2409
8	2410	9	2411	10	2412	11	2413
12	2414	13	2415	14	2416	15	2417
16	2418	17	2419	18	2420	19	2421
20	2422	21	2423	22	2424	23	2425
24	2426	25	2427	26	2428	27	2429
28	2430	29	2431	30	2432	31	2433
32	2434	33	2435	34	2436	35	2437
36	2438	37	2439	38	2440	39	2441
40	2442	41	2443	42	2444	43	2445
44	2446	45	2447	46	2448	47	2449
48	2450	49	2451	50	2452	51	2453
52	2454	53	2455	54	2456	55	2457
56	2458	57	2459	58	2460	59	2461
60	2462	61	2463	62	2464	63	2465
64	2466	65	2467	66	2468	67	2469
68	2470	69	2471	70	2472	71	2473

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Channel No.	Frequency (MHz)	Channel No.	Frequency (MHz)	Channel No.	Frequency (MHz)	Channel No.	Frequency (MHz)
72	2474	73	2475	74	2476	75	2477
76	2478	77	2479	78	2480	N/A	N/A

4.4 Test Mode

All test mode(s) and condition(s) mentioned were considered and evaluated respectively by performing full tests; the worst data were recorded and reported.

Test mode Low channel		Middle channel	High channel
Charging +Transmitting	2402MHz	2441MHz	2480MHz

5 Equipment Used during Test

5.1 Equipments List

Condu	cted Emissions					
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Calibration Date	Calibration Due Date
1	EMI Test Receiver	R&S	ESCI	100947	2017-09-12	2018-09-11
2	LISN	R&S	ENV216	100115	2017-09-12	2018-09-11
3	Cable	Тор	TYPE16(3.5M)	-	2017-09-12	2018-09-11
3m Sei	mi-anechoic Chamber	for Radiation Emis	sions			
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Calibration Date	Calibration Due Date
1	Spectrum Analyzer	R&S	FSP30	100091	2017-04-29	2018-04-28
2	Broad-band Horn Antenna(1-18GHz)	SCHWARZBECK	BBHA 9120 D	667	2017-04-09	2018-04-08
3	Broadband Preamplifier	COMPLIANCE DIRECTION	PAP-1G18	2004	2017-04-13	2018-04-12
4	Coaxial Cable (above 1GHz)	Тор	1GHz-18GHz	EW02014-7	2017-04-13	2018-04-12
5	Spectrum Analyzer	R&S	FSP40	100501	2017-10-20	2018-10-19
6	Broad-band Horn Antenna(18-40GHz)	SCHWARZBECK	BBHA 9170	BBHA917065 1	2017-10-25	2018-10-24
7	Microwave Broadband Preamplifier (18-40GHz)	SCHWARZBECK	BBV 9721	100472	2017-10-25	2018-10-24
8	Cable	Тор	18-40GHz	-	2017-10-25	2018-10-24
3m Sei	mi-anechoic Chamber	for Radiation Emis	sions			
Item	Equipment	Manufacturer	Model No.	Serial No	Last Calibration Date	Calibration Due Date
1	Test Receiver	R&S	ESCI	101296	2017-04-13	2018-04-12
2	Trilog Broadband Antenna	SCHWARZBECK	VULB9160	9160-3325	2017-04-13	2018-04-12
3	Active Loop Antenna	Beijing Dazhi	ZN30900A	-	2017-04-09	2018-04-08
4	Amplifier	ANRITSU	MH648A	M43381	2017-04-13	2018-04-12
5	Cable	HUBER+SUHNER	CBL2	525178	2017-04-13	2018-04-12
6	Coaxial Cable (below 1GHz)	Тор	TYPE16(13M)	-	2017-09-12	2018-09-11
RF Co	nducted Testing					
Item	Equipment	Manufacturer	Model No.	Serial No.	Last Calibration Date	Calibration Due Date

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1.	Signal Analyzer (9k~26.5GHz)	Agilent	N9010A	MY50520207	2017-09-12	2018-09-11
2	Spectrum Analyzer	R&S	FSL6	100959	2017-09-12	2018-09-11

5.2 Measurement Uncertainty

Parameter	Uncertainty
Radio Frequency	± 1 x 10 ⁻⁶
RF Power	± 1.0 dB
RF Power Density	± 2.2 dB
Dedicted Couriers Emissions test	± 5.03 dB (Bilog antenna 30M~1000MHz)
Radiated Spurious Emissions test	± 5.47 dB (Horn antenna 1000M~25000MHz)
Conducted Emissions test	± 3.64 dB (AC mains 150KHz~30MHz)
Confidence interval: 95%. Confidence fa	actor:k=2

5.3 Subcontracted

Test items: N/A

Whether parts of tests for the product have been subcontracted to other labs							
☐ Yes							
If Yes, list the related test items and lab information:							
Test Lab: N/A							
Lab address: N/A							

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6 Test Summary

Test Items	Test Requirement	Result
	15.205(a)	
Radiated Spurious Emissions	15.209	Pass
	15.247(d)	
Conducted Spurious emissions	15.247(d)	Pass
Donal adam	15.247(d)	Dana
Band edge	15.205(a)	Pass
Conduct Emission	15.207	Pass
Bandwidth	15.247(a)(1)	Pass
Maximum Peak Output Power	15.247(b)(1)	Pass
Frequency Separation	15.247(a)(1)	Pass
Number of Hopping Frequency	15.247(a)(1)(iii)	Pass
Dwell time	15.247(a)(1)(iii)	Pass
Antenna Requirement	15.203	Pass
RF Exposure	1.1307(b)(1)	Pass
Note: Pass=Compliance; Fail=Not Compliar	nce; N/A=Not Applicable.	

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7 Conducted Emission

Test Requirement: FCC CFR 47 Part 15 Section 15.207

Test Method: ANSI C63.10:2013

Test Result: PASS

Frequency Range: 150kHz to 30MHz

Class/Severity: Class B

Limit: Frequ

Fraguency (MHz)	Limit (dBμV)				
Frequency (MHz)	Qsi-peak	Average			
0.15 to 0.5	66 to 56*	56 to 46*			
0.5 to 5	50	60			
5 to 30	60	50			

7.1 E.U.T. Operation

Operating Environment:

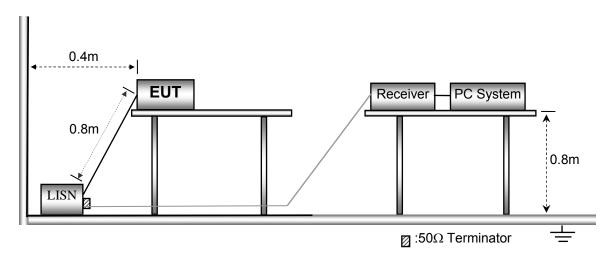
Temperature: 22.8 °C
Humidity: 52.6 % RH
Atmospheric Pressure: 101.2kPa

EUT Operation:

The test was performed in Charging + Transmitting mode, the worst test data (GFSK modulation Low channel) were shown in the report.

7.2 EUT Setup

The conducted emission tests were performed using the setup accordance with the ANSI C63.10:2013.



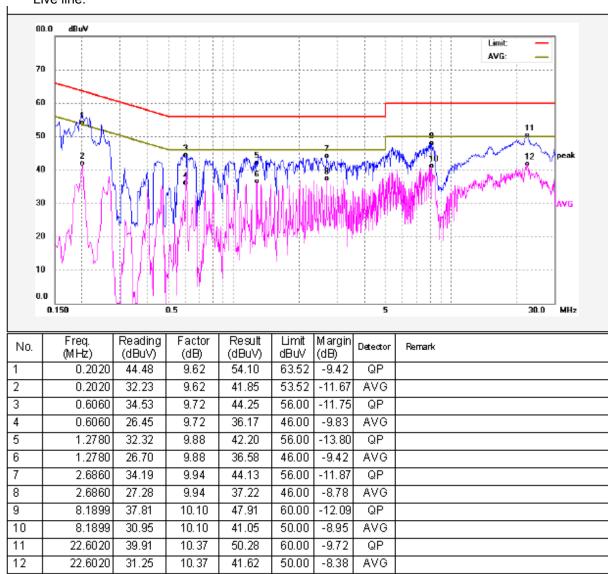
7.3 Measurement Description

The maximised peak emissions from the EUT was scanned and measured for both the Live and Neutral Lines. Quasi-peak & average measurements were performed if peak emissions were within 6dB of the average limit line.

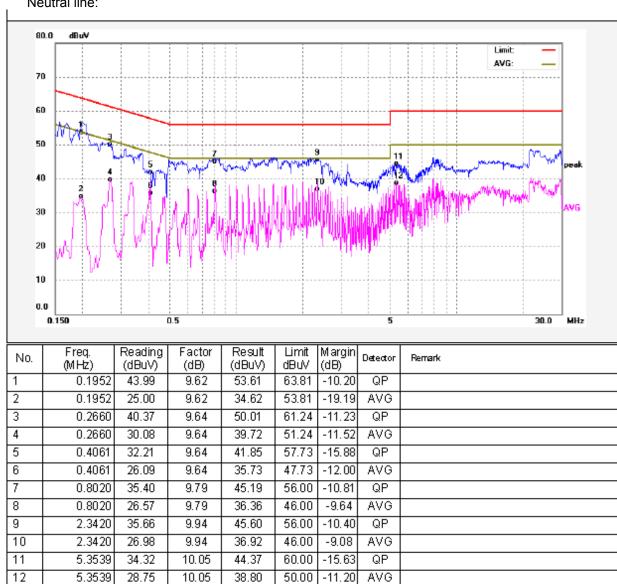
7.4 Conducted Emission Test Result

Remark: only the worst data (GFSK modulation Low channel mode) were reported

Live line:



Neutral line:



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8 Radiated Spurious Emissions

Test Requirement: FCC CFR47 Part 15 Section 15.209 & 15.247

Test Method: ANSI C63.10:2013

Test Result: PASS
Measurement Distance: 3m

Limit:

_	Field Stre	ngth	Field Strength Limit at 3m Measurement Dist			
Frequency (MHz)	uV/m	Distance (m)	uV/m	dBuV/m		
0.009 ~ 0.490	2400/F(kHz)	300	10000 * 2400/F(kHz)	20log ^{(2400/F(kHz))} + 80		
0.490 ~ 1.705	24000/F(kHz)	30	100 * 24000/F(kHz)	20log ^{(24000/F(kHz))} + 40		
1.705 ~ 30	30	30	100 * 30	20log ⁽³⁰⁾ + 40		
30 ~ 88	100	3	100	20log ⁽¹⁰⁰⁾		
88 ~ 216	150	3	150	20log ⁽¹⁵⁰⁾		
216 ~ 960	200	3	200	20log ⁽²⁰⁰⁾		
Above 960	500	3	500	20log ⁽⁵⁰⁰⁾		

8.1 EUT Operation

Operating Environment:

Atmospheric Pressure:

Temperature: 23.5 °C Humidity: 51.1 % RH

EUT Operation:

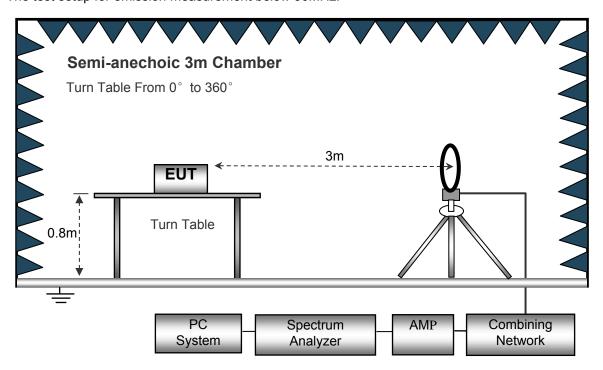
The test was performed in Charging + Transmitting mode, the worst test data (GFSK modulation) were shown in the report.

101.2kPa

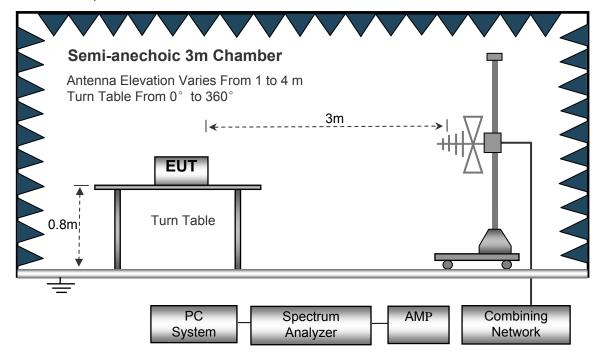
8.2 Test Setup

The radiated emission tests were performed in the 3m Semi- Anechoic Chamber test site, using the setup accordance with the ANSI C63.10:2013.

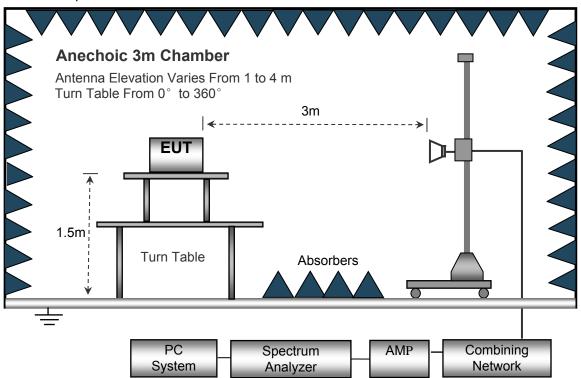
The test setup for emission measurement below 30MHz.



The test setup for emission measurement from 30 MHz to 1 GHz.



The test setup for emission measurement above 1 GHz.



Spectrum Analyzer Setup 8.3

Sweep Speed	. Auto
IF Bandwidth	.10kHz
Video Bandwidth	.10kHz

Resolution Bandwidth......10kHz

30MHz ~ 1GHz

Sweep Speed	Auto
Detector	PK
Resolution Bandwidth	100kHz
Video Bandwidth	200ドロュ

Above 1GHz

Sweep Speed	Auto
Detector	.PK
Resolution Bandwidth	1MHz
Video Bandwidth	3MHz
Detector	Ave.
Resolution Bandwidth	1MHz
Video Bandwidth	.10Hz

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8.4 Test Procedure

1. The EUT is placed on a turntable, which is 0.8m above ground plane for below 1GHz and 1.5m for above 1GHz.

- 2. The turntable shall be rotated for 360 degrees to determine the position of maximum emission level.
- 3. EUT is set 3m away from the receiving antenna, which is moved from 1m to 4m to find out the maximum emissions. The spectrum was investigated from the lowest radio frequency signal generated in the device, without going below 9 kHz, up to the tenth harmonic of the highest fundamental frequency or to 40 GHz, whichever is lower.
- 4. Maximum procedure was performed on the six highest emissions to ensure EUT compliance.
- 5. And also, each emission was to be maximized by changing the polarization of receiving antenna both horizontal and vertical.
- 6. Repeat above procedures until the measurements for all frequencies are complete.
- 7. The radiation measurements are tested under 3-axes(X,Y,Z) position(X denotes lying on the table, Y denotes side stand and Z denotes vertical stand), After pre-test, It was found that the worse radiation emission was get at the Z position. So the data shown was the Z position only.

8.5 Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Factor and Cable Factor, and subtracting the Amplifier Gain from the Amplitude reading. The basic equation is as follows:

Corr. Ampl. = Indicated Reading + Antenna Factor + Cable Factor - Amplifier Gain

The "Margin" column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of -7dB means the emission is 7dB below the maximum limit for Class B. The equation for margin calculation is as follows:

Margin = Corr. Ampl. – Limit

8.6 Summary of Test Results

Test Frequency: 9 KHz~30 MHz

The measurements were more than 20 dB below the limit and not reported.

Test Frequency: 30MHz ~ 18GHz

Remark: only the worst data (GFSK modulation) were reported.

_	Receiver		Turn	RX An	tenna	Corrected	Corrected		
Frequency	Reading	Detector	table Angle Height Polar Factor Amp	Amplitude	Limit	Margin			
(MHz)	(dBµV)	(PK/QP/Ave)	Degree	(m)	(H/V)	(dB)	(dBµV/m)	(dBµV/m)	(dB)
			GF	SK Low	Channel				
286.63	36.25	QP	103	1.4	Н	-13.35	22.90	46.00	-23.10
286.63	40.28	QP	129	1.2	V	-13.35	26.93	46.00	-19.07
4804.00	48.11	PK	262	1.7	V	-1.06	47.05	74.00	-26.95
4804.00	43.25	Ave	262	1.7	V	-1.06	42.19	54.00	-11.81
7206.00	40.18	PK	225	1.2	Н	1.33	41.51	74.00	-32.49
7206.00	35.29	Ave	225	1.2	Н	1.33	36.62	54.00	-17.38
2344.16	45.39	PK	49	1.0	V	-13.19	32.20	74.00	-41.80
2344.16	37.28	Ave	49	1.0	V	-13.19	24.09	54.00	-29.91
2380.81	43.11	PK	39	2.0	Н	-13.14	29.97	74.00	-44.03
2380.81	38.77	Ave	39	2.0	Н	-13.14	25.63	54.00	-28.37
2493.79	44.52	PK	160	1.1	V	-13.08	31.44	74.00	-42.56
2493.79	36.92	Ave	160	1.1	V	-13.08	23.84	54.00	-30.16

_	Receiver		Turn	RX An	tenna	Corrected	Corrected Amplitude	Limit	Margin
Frequency	Reading	Detector	table Angle	Height	Polar	Factor			
(MHz)	(dBµV)	(PK/QP/Ave)	Degree	(m)	(H/V)	(dB)	(dBµV/m)	(dBµV/m)	(dB)
	GFSK Middle Channel								
286.63	37.49	QP	58	1.9	Н	-13.35	24.14	46.00	-21.86
286.63	40.29	QP	210	1.2	V	-13.35	26.94	46.00	-19.06
4882.00	48.12	PK	353	1.8	V	-0.62	47.50	74.00	-26.50
4882.00	43.02	Ave	353	1.8	V	-0.62	42.40	54.00	-11.60
7323.00	39.66	PK	357	1.8	Н	2.21	41.87	74.00	-32.13
7323.00	34.73	Ave	357	1.8	Н	2.21	36.94	54.00	-17.06
2322.73	46.70	PK	215	1.9	V	-13.19	33.51	74.00	-40.49
2322.73	38.56	Ave	215	1.9	V	-13.19	25.37	54.00	-28.63
2378.30	44.54	PK	190	1.0	Н	-13.14	31.40	74.00	-42.60
2378.30	36.88	Ave	190	1.0	Н	-13.14	23.74	54.00	-30.26
2485.90	44.27	PK	178	1.1	V	-13.08	31.19	74.00	-42.81
2485.90	36.02	Ave	178	1.1	V	-13.08	22.94	54.00	-31.06

_	Receiver		Turn	RX An	tenna	Corrected	Corrected		
Frequency	Reading	Detector	table Angle		Amplitude	Limit	Margin		
(MHz)	(dBµV)	(PK/QP/Ave)	Degree	(m)	(H/V)	(dB)	(dBµV/m)	(dBµV/m)	(dB)
	GFSK High Channel								
286.63	36.29	QP	1	2.0	Н	-13.35	22.94	46.00	-23.06
286.63	40.35	QP	44	1.4	V	-13.35	27.00	46.00	-19.00
4960.00	48.11	PK	21	1.1	V	-0.24	47.87	74.00	-26.13
4960.00	42.08	Ave	21	1.1	V	-0.24	41.84	54.00	-12.16
7440.00	38.45	PK	140	1.0	Н	2.84	41.29	74.00	-32.71
7440.00	35.66	Ave	140	1.0	Н	2.84	38.50	54.00	-15.50
2344.20	45.64	PK	126	1.7	V	-13.19	32.45	74.00	-41.55
2344.20	39.45	Ave	126	1.7	V	-13.19	26.26	54.00	-27.74
2366.75	44.31	PK	127	1.3	Н	-13.14	31.17	74.00	-42.83
2366.75	36.08	Ave	127	1.3	Н	-13.14	22.94	54.00	-31.06
2484.68	42.39	PK	346	1.2	V	-13.08	29.31	74.00	-44.69
2484.68	37.66	Ave	346	1.2	V	-13.08	24.58	54.00	-29.42

Test Frequency: 18GHz~25GHz

The measurements were more than 20 dB below the limit and not recorded

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9 Conducted Spurious Emissions

Test Requirement: FCC CFR47 Part 15 Section 15.247

Test Method: ANSI C63.10:2013

Test Result: PASS

Limit:

In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in Section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in Section 15.205(a), must also comply with the radiated emission limits specified in Section 15.209(a) (see Section 15.205(c)).

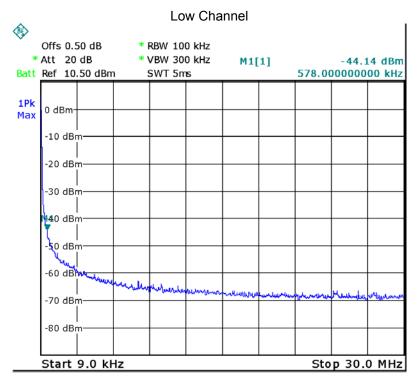
9.1 Test Procedure

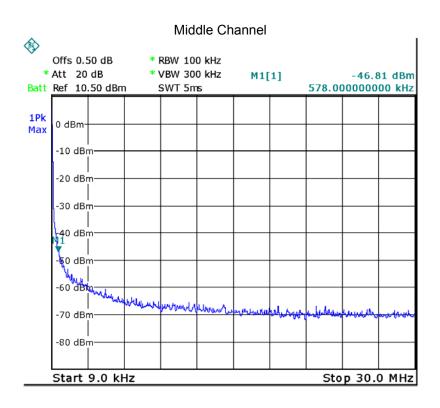
- 1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum;
- 2. Set the spectrum analyzer:

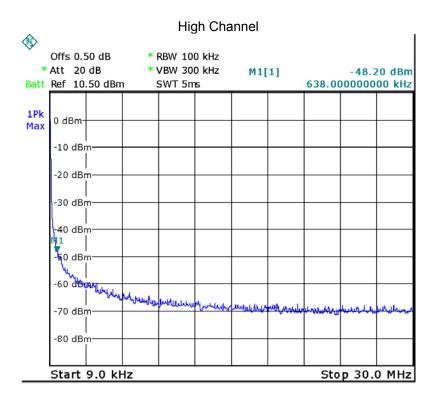
RBW = 100kHz, VBW = 300kHz, Sweep = auto Detector function = peak, Trace = max hold

9.2 Test Result

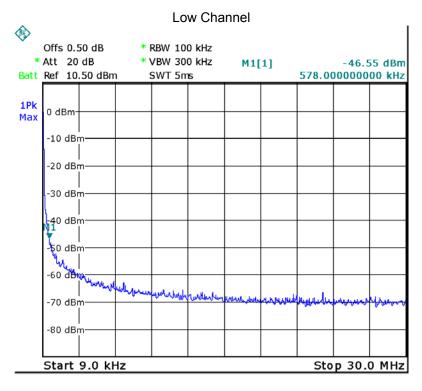
9 KHz - 30MHz GFSK

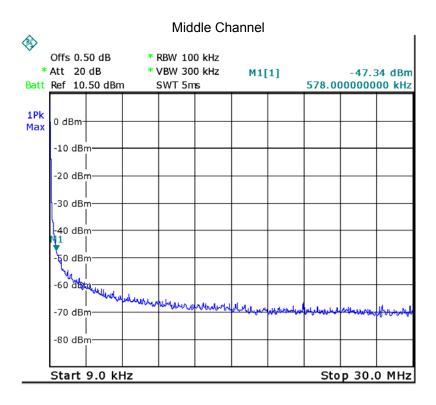


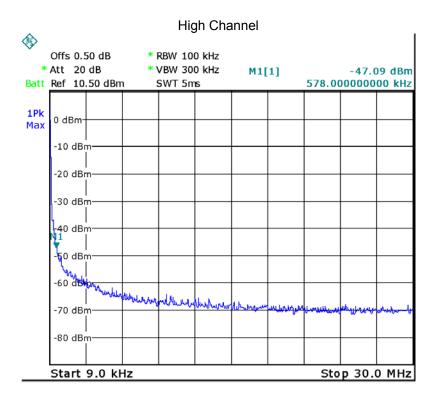




$\pi/4DQPSK$

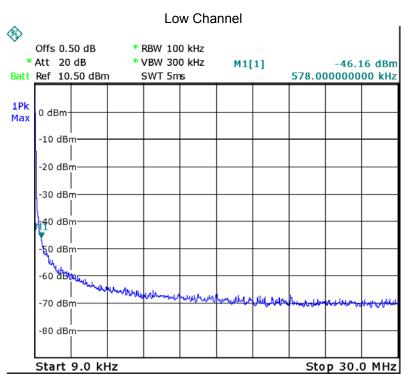


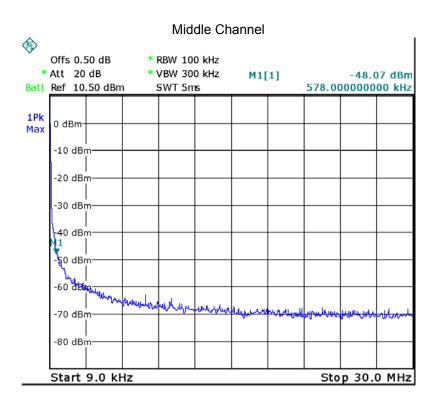


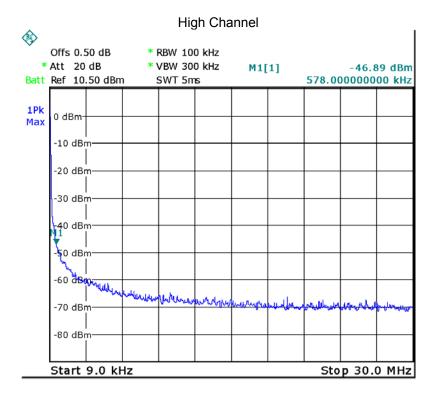


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8DPSK







30MHz - 25GHz

GFSK Low Channel



GFSK Middle Channel



GFSK High Channel



Π /4 DQPSK Low Channel



Π /4 DQPSK Middle Channel



Π /4 DQPSK High Channel



8DPSK Low Channel



8DPSK Middle Channel



8DPSK High Channel



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10 Band Edge Measurement

Test Requirement: Section 15.247(d) In addition, radiated emissions which fall in

the restricted bands. as defined in Section 15.205(a), must also comply with the radiated emission limits specified in Section

15.209(a) (see Section 15.205(c)).

Test Method: ANSI C63.10:2013

Test Limit: Regulation 15.247 (d),In any 100 kHz bandwidth outside the

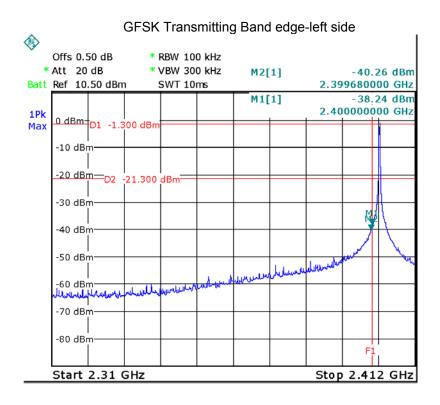
frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in §15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).

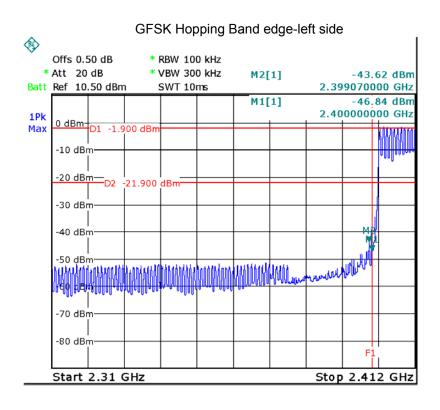
Test Mode: Transmitting

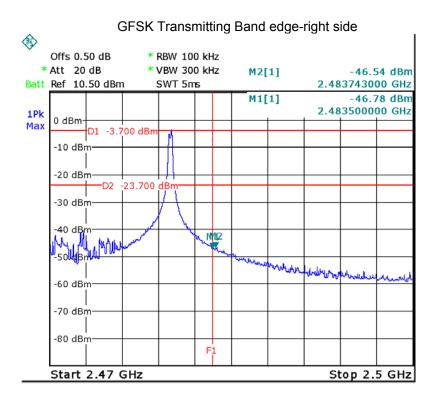
10.1 Test Procedure

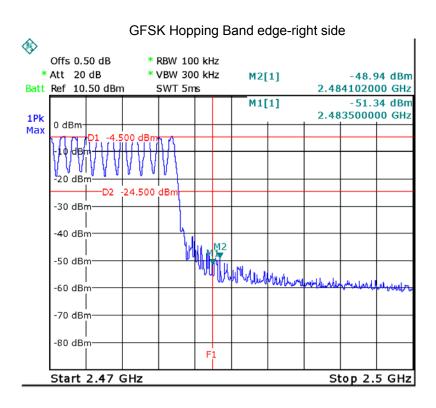
- 1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum;
- Set the spectrum analyzer: RBW = 100kHz, VBW = 300kHz, Sweep = auto
 Detector function = peak, Trace = max hold

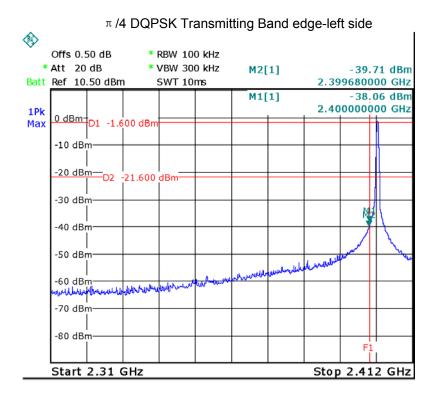
10.2 Test Result

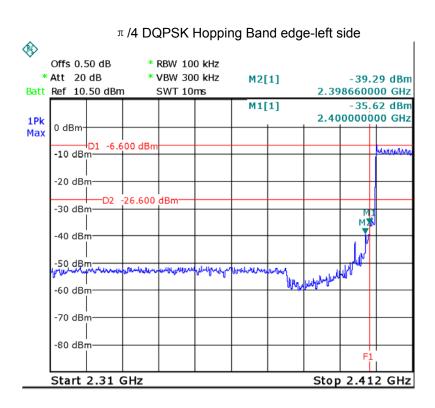


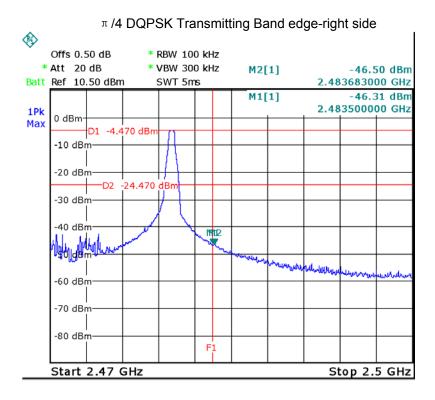


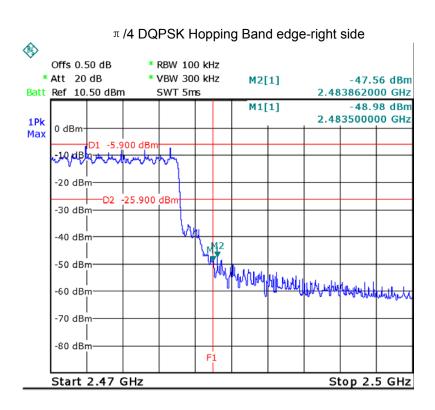


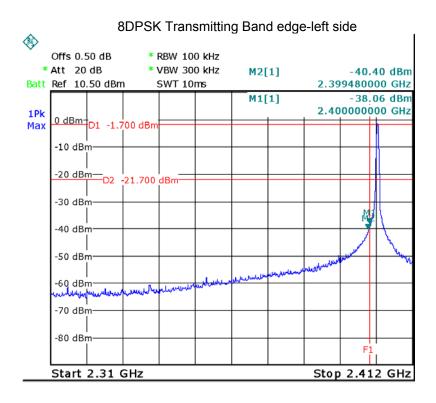


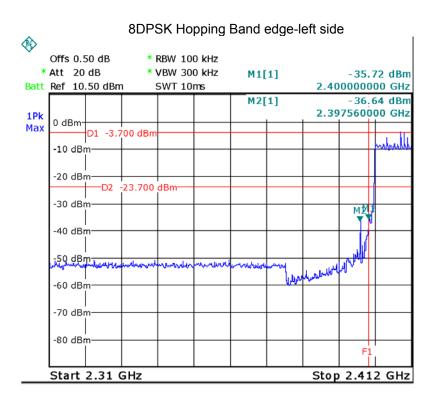


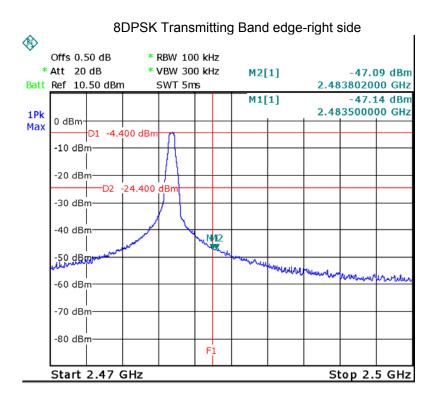


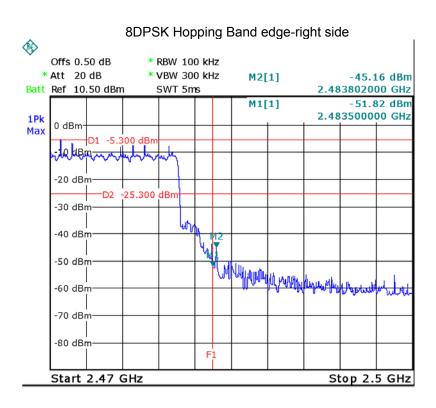












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11 Bandwidth Measurement

Test Requirement: FCC CFR47 Part 15 Section 15.247

Test Method: ANSI C63.10:2013

Test Mode: Test in fixing operating frequency at low, Middle, high channel.

11.1 Test Procedure

1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum;

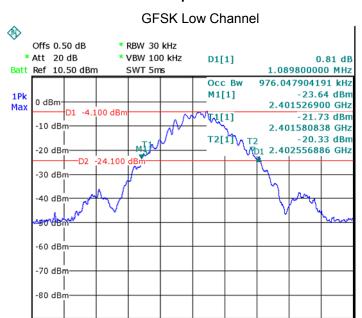
2. Set the spectrum analyzer: RBW = 30kHz, VBW = 100kHz

11.2 Test Result

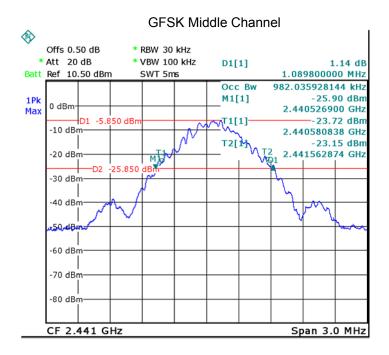
Modulation	Test Channel	20dB Bandwidth(MHz)	99% Bandwidth(MHz)	
GFSK	Low	1.090	0.976	
GFSK	Middle	1.090	0.982	
GFSK	High	High 1.090		
π /4 DQPSK	Low	1.377	1.257	
π /4 DQPSK	Middle	1.377	1.246	
π /4 DQPSK	High	1.377	1.246	
8DPSK	Low	1.365	1.275	
8DPSK	Middle	1.365	1.269	
8DPSK	High	1.365	1.269	

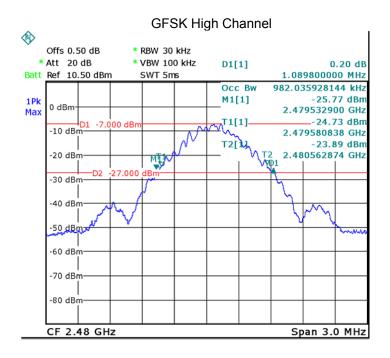
CF 2.402 GHz

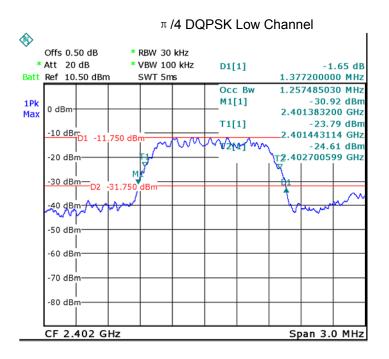
Test plots

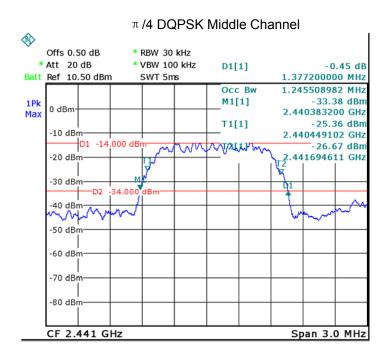


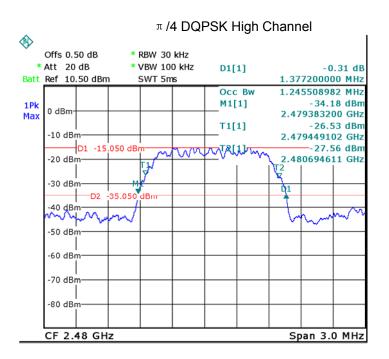
Span 3.0 MHz

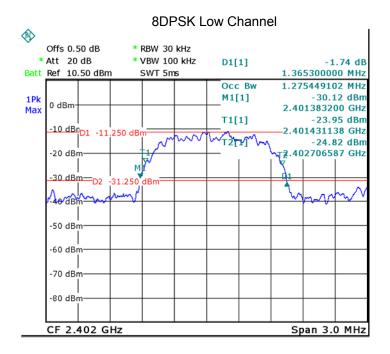


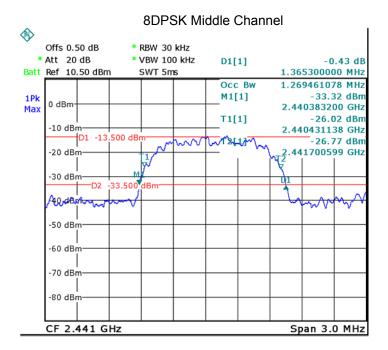


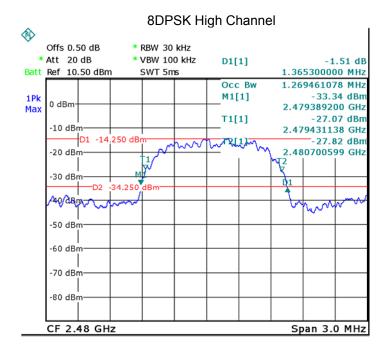












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12 Maximum Peak Output Power

Test Requirement: FCC CFR47 Part 15 Section 15.247

Test Method: ANSI C63.10:2013

Test Limit: Regulation 15.247 (b)(1), For frequency hopping systems

operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400-2483.5 MHz

band: 0.125 watts.

Test mode: Test in fixing frequency transmitting mode.

12.1 Test Procedure

1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum.

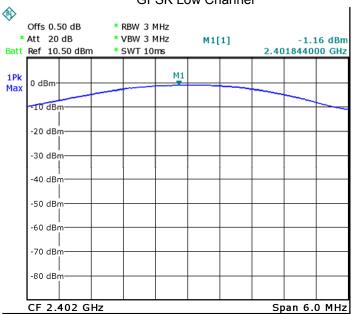
- 2. Set the spectrum analyzer: RBW = 3MHz. VBW = 3MHz. Sweep = auto; Detector Function = Peak.
- 3. Keep the EUT in transmitting at lowest, medium and highest channel individually. Record the max value.

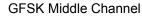
12.2 Test Result

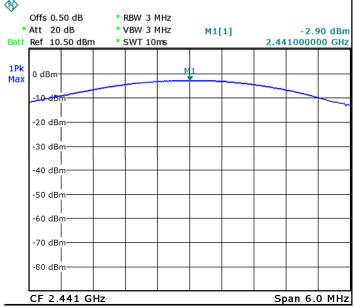
Modulation	Test Channel	Output Power (dBm)	Limit (dBm)
GFSK	Low	-1.16	30
GFSK	Middle	-2.90	30
GFSK	High	-3.72	30
π /4 DQPSK	Low	-1.31	21
π /4 DQPSK	Middle	-2.91	21
π /4 DQPSK	High	-3.68	21
8DPSK	Low	-1.15	21
8DPSK	Middle	-2.87	21
8DPSK	High	-3.69	21

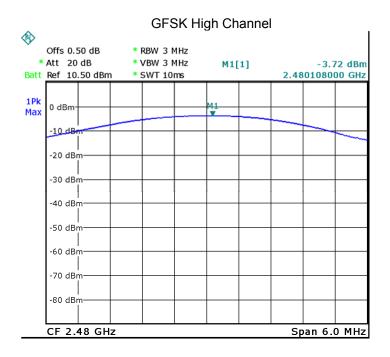
Test plots

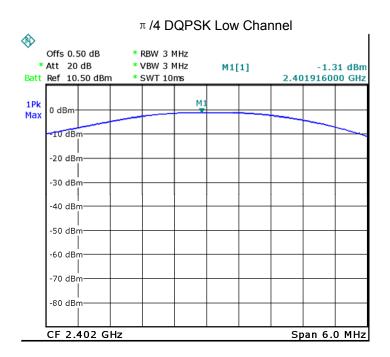
GFSK Low Channel

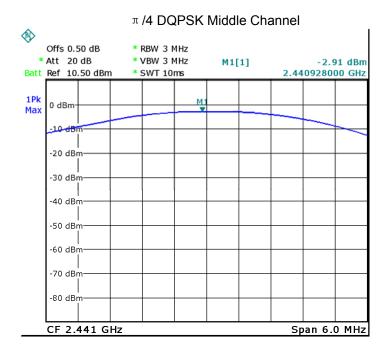


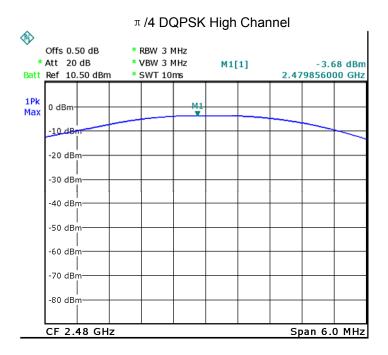


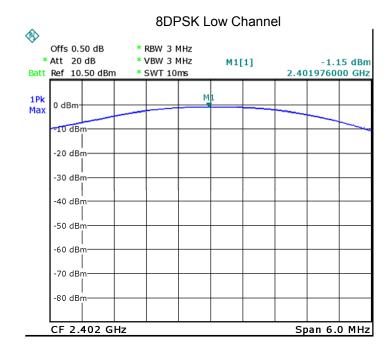


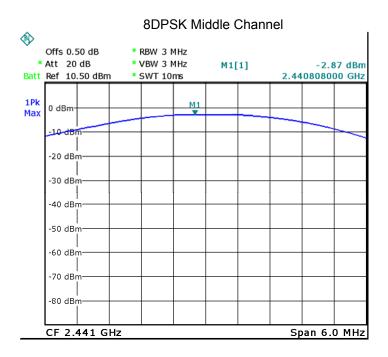


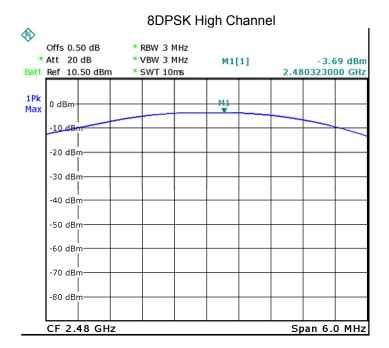












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13 Hoping Channel Separation

Test Requirement: FCC CFR47 Part 15 Section 15.247

Test Method: ANSI C63.10:2013

Test Limit: Regulation 15.247(a)(1) Frequency hopping systems shall have

hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 0.125W.

Test Mode: Test in hopping transmitting operating mode.

13.1 Test Procedure

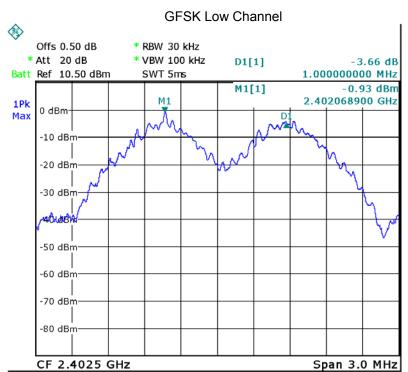
1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum.

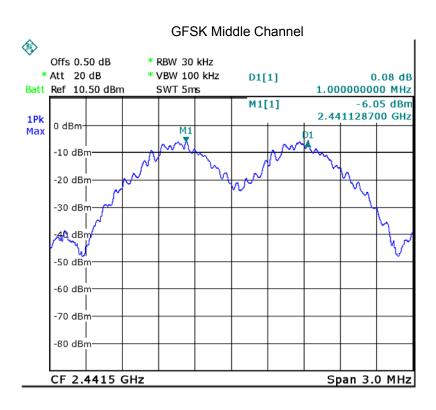
- Set the spectrum analyzer: RBW = 30kHz. VBW = 100kHz , Span = 3.0MHz. Sweep = auto;
 Detector Function = Peak. Trace = Max hold.
- 3. Allow the trace to stabilize. Use the marker-delta function to determine the separation between the peaks of the adjacent channels. The limit is specified in one of the subparagraphs of this Section Submit this plot.

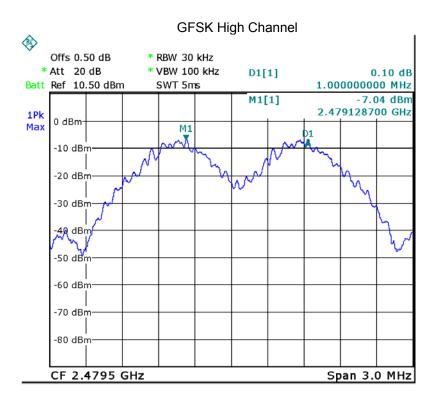
13.2 Test Result

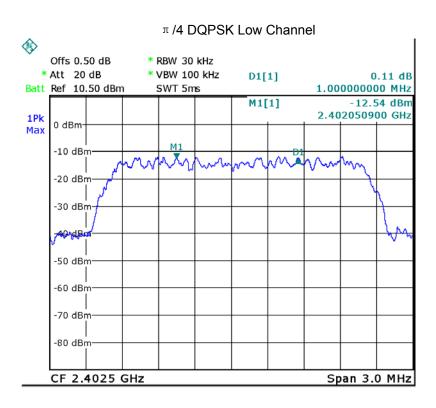
Modulation	Test Channel	Separation (MHz)	Result	
GFSK	Low	Low 1.000		
GFSK	Middle	1.000	PASS	
GFSK	High	1.000	PASS	
π /4 DQPSK	Low	1.000	PASS	
π /4 DQPSK	Middle	1.000	PASS	
π /4 DQPSK	High	1.000	PASS	
8DPSK	Low	1.000	PASS	
8DPSK	Middle	1.000	PASS	
8DPSK	High	1.000	PASS	

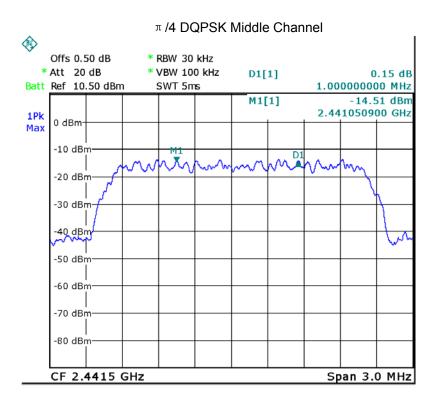
Test plots

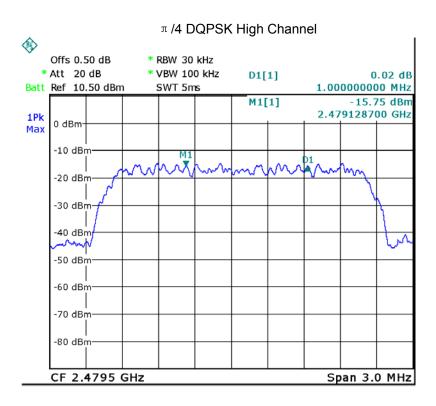


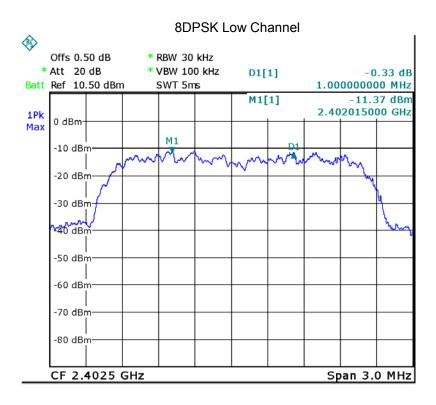


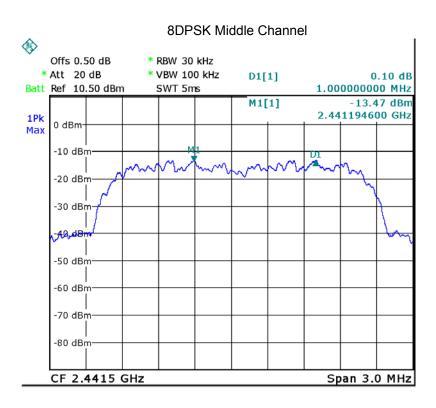


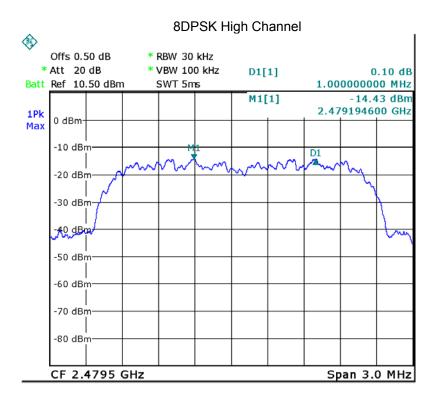












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Number of Hopping Frequency 14

Test Requirement: FCC CFR47 Part 15 Section 15.247

Test Method: ANSI C63.10:2013

Test Limit: Regulation 15.247 (a)(1)(iii) Frequency hopping systems in

the 2400-2483.5 MHz band shall use at least 15 channels.

Test Mode: Test in hopping transmitting operating mode.

14.1 Test Procedure

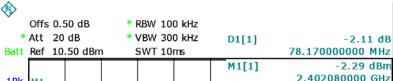
1. Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum.

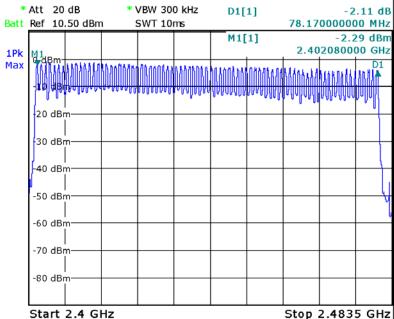
- 2. Set the spectrum analyzer: RBW = 100 KHz. VBW = 300 KHz. Sweep = auto; Detector Function = Peak. Trace = Max hold.
- 3. Allow the trace to stabilize. It may prove necessary to break the span up to sections. in order to clearly show all of the hopping frequencies. The limit is specified in one of the subparagraphs of this Section.
- 4. Set the spectrum analyzer: Start Frequency = 2.4GHz, Stop Frequency = 2.483GHz. Sweep=auto;

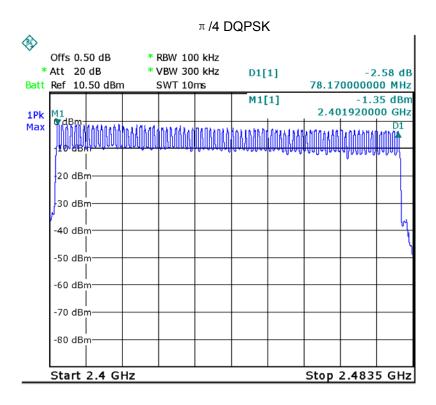
14.2 Test Result

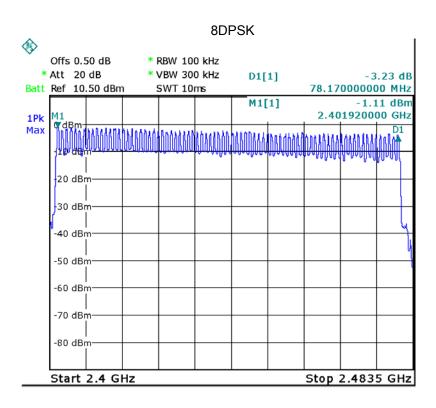
Test Plots:

79 Channels in total **GFSK**









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15 Dwell Time

Test Requirement: FCC CFR47 Part 15 Section 15.247

Test Method: ANSI C63.10:2013

Test Limit: Regulation 15.247(a)(1)(iii) Frequency hopping systems in

the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided

that a minimum of 15 channels are used.

Test Mode: Test in hopping transmitting operating mode.

15.1 Test Procedure

 Remove the antenna from the EUT and then connect a low RF cable from the antenna port to the spectrum.

- 2. Set spectrum analyzer span = 0. Centred on a hopping channel;
- Set RBW = 1MHz and VBW = 3MHz.Sweep = as necessary to capture the entire dwell time per hopping channel. Set the EUT for DH5, DH3 and DH1 packet transmitting.
- 4. Use the marker-delta function to determine the dwell time. If this value varies with different modes of operation (e.g., data rate, modulation format, etc.), repeat this test for each variation. The limit is specified in one of the subparagraphs of this Section. Submit this plot(s).

15.2 Test Result

DH5 Packet permit maximum 1600 / 79 / 6 hops per second in each channel (5 time slots RX, 1 time slot TX).

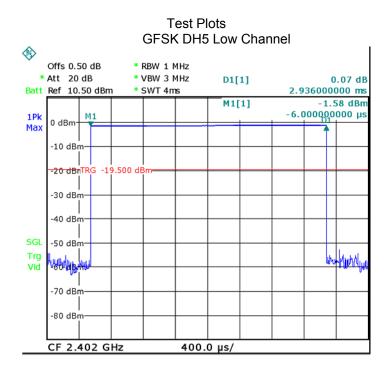
DH3 Packet permit maximum 1600 / 79 / 4 hops per second in each channel (3 time slots RX, 1 time slot TX).

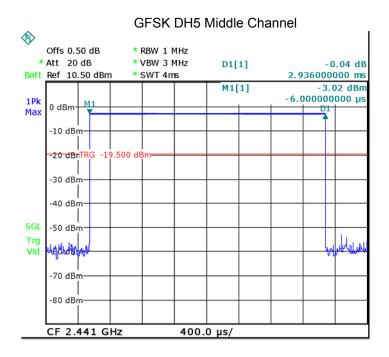
DH1 Packet permit maximum 1600 / 79 /2 hops per second in each channel (1 time slot RX, 1 time slot TX). So, the Dwell Time can be calculated as follows:

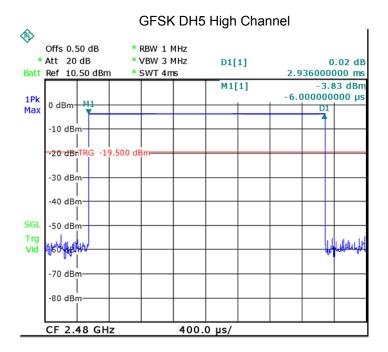
Data Packet	Dwell Time(s)	
DH5	1600/79/6*0.4*79*(MkrDelta)/1000	
DH3	1600/79/4*0.4*79*(MkrDelta)/1000	
DH1	1600/79/2*0.4*79*(MkrDelta)/1000	
Remark: Mkr Delta is once pulse time.		

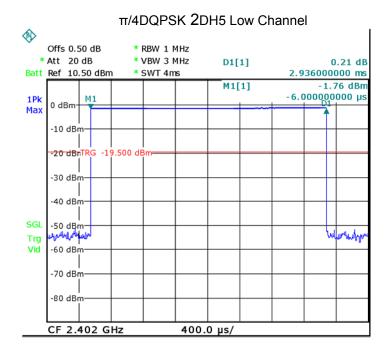
Modulation	Data Packet	Channel	pulse time(ms)	Dwell Time(s)	Limits(s)
GFSK	DH5	Low	2.936	0.313	0.4
		middle	2.936	0.313	0.4
		High	2.936	0.313	0.4
π/4DQPSK	2DH5	Low	2.936	0.313	0.4
		middle	2.936	0.313	0.4
		High	2.936	0.313	0.4
8DPSK	3DH5	Low	2.936	0.313	0.4
		middle	2.936	0.313	0.4
		High	2.936	0.313	0.4

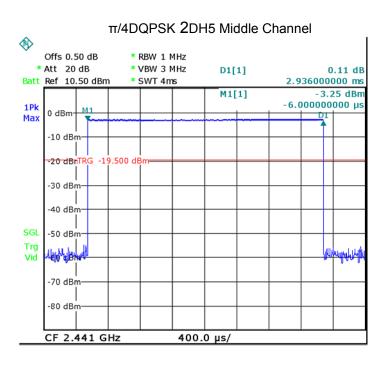
Remark: Only the worst-case is recorded.

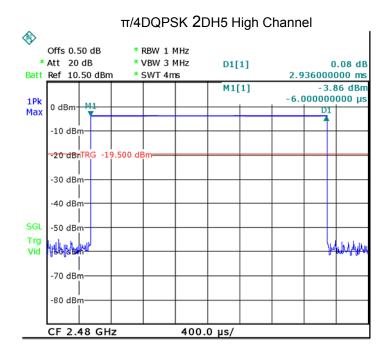


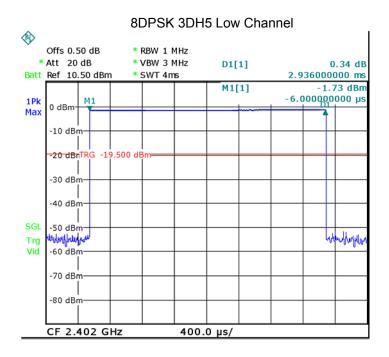


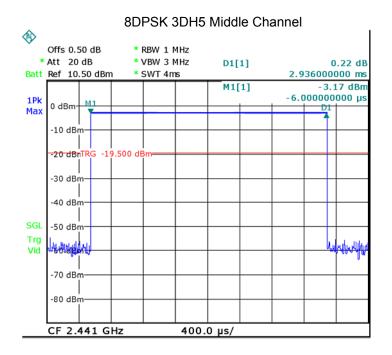


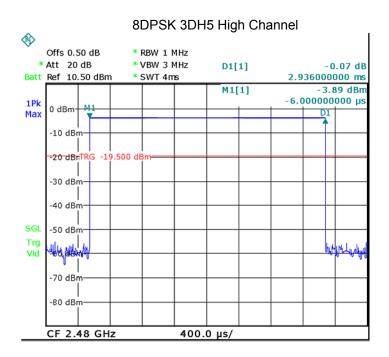












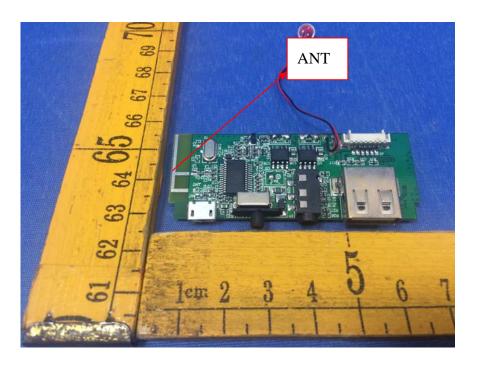
16 Antenna Requirement

An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section. The manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited. This requirement does not apply to carrier current devices or to devices operated under the provisions of §15.211, §15.213, §15.217, §15.219, or §15.221. Further, this requirement does not apply to intentional radiators that must be professionally installed, such as perimeter protection systems and some field disturbance sensors, or to other intentional radiators which, in accordance with §15.31(d), must be measured at the installation site. However, the installer shall be responsible for ensuring that the proper antenna is employed so that the limits in this part are not exceeded.

For intentional device, according to FCC 47 CFR Section 15.203, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device.

Result:

The EUT has one PCB Printed Antenna, the gain is 0dBi. meets the requirements of FCC 15.203.



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17 FCC ID: 2ALR9-KDL-BT1512 RF Exposure

Note: Please refer to RF Exposure test report: WTS17S1195179-2E.

18 Photographs-Model KDL-BT1512 Test Setup Photos

Note: Please refer to Photos: WTS17S1195179-3E.

19 Photographs - Constructional Details

19.1 Model KDL-BT1512-External Photos

Note: Please refer to Photos: WTS17S1195179-3E.

19.2 Model KDL-BT1512-Internal Photos

Note: Please refer to Photos: WTS17S1195179-3E.

=====End of Report=====